

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of Applicants:

Date: July 28, 2009

Beaman et al.

Group Art Unit: 3729

Serial No.: 09/921,867

Examiner: A. D. Tugbang

Filed: August 3, 2001

Docket No.: YOR919930028US6

For: HIGH DENSITY INTEGRATED CIRCUIT APPARATUS, TEST PROBE AND  
METHODS OF USE THEREOF

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**RESPONSE TO NON-FINAL OFFICE ACTION DATED MARCH 4, 2008**

In response to Non-Final Office Action dated March 4, 2008 please consider the  
following: